

Notice of References Cited	Application/Control No. 10/710,235	Applicant(s)/Patent Under Reexamination TAI ET AL.	
	Examiner Yelena G. Gakh, Ph.D.	Art Unit 1797	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11339935 A	12-1999	Japan	TANAKA, SATOSHI	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Shigeishi "A field ion investigation of oxygen on tungsten", Can. J. Chem., 1973, v. 51, pp. 997-1003
	V	Bloomer et al. "A simple detector for small leaks using a thoriated tungsten emitter with oxygen as probe gas", J. Scientific Instruments, 1960, v. 37, pp. 306-307
	W	Bussjager et al. "A spinning disk test stand for two-color, tungsten oxide based optical memory system", Aerospace Conference, 1999. Proceedings. 1999 IEEE, Publication Date: 1999, v.3, pp. 329-342
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.